

## Product Summary

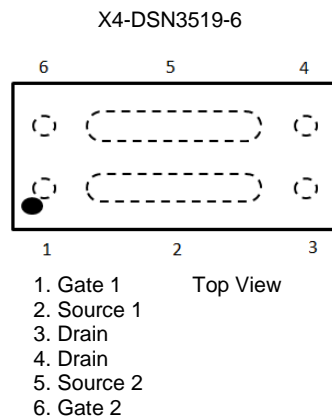
BV <sub>SSS</sub>	R <sub>SS(ON)</sub> Typ	I <sub>S</sub> Max T <sub>A</sub> = +25°C
30V	4.8mΩ @ V <sub>GS</sub> = 8V	13.0A
	6.3mΩ @ V <sub>GS</sub> = 4.5V	11.5A

## Description

This new generation MOSFET is designed to minimize on-state resistance (R<sub>SS(ON)</sub>) yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

## Applications

- Battery Management
- Load Switch
- Battery Protection

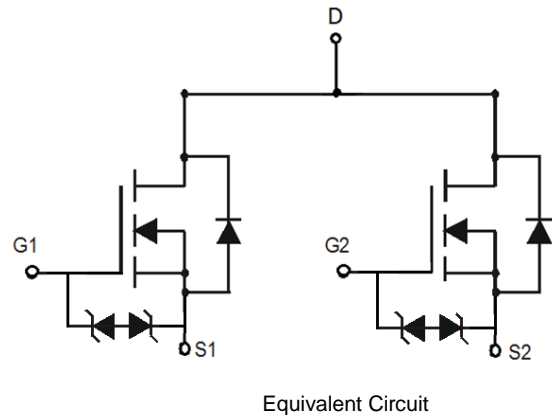


## Features

- CSP with Footprint 3.5mm × 1.9mm
- Height = 0.11mm for Low Profile
- ESD Protection of Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- Halogen- and Antimony-Free. "Green" Device (Note 3)**

## Mechanical Data

- Case: X4-DSN3519-6
- Terminal Connections: See Diagram Below
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish — NiPdAu or NiAu. Solderable per MIL-STD-202, Method 208 (M4)
- Weight: 0.0012 grams (Approximate)

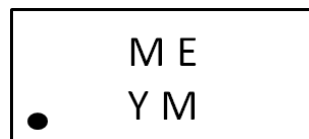


## Ordering Information (Note 4)

Part Number	Case	Packaging
DMN3006SCA6-7	X4-DSN3519-6	3000/Tape & Reel

- Notes:
- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
  - See <https://www.diodes.com/quality/lead-free/> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
  - Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
  - For packaging details, go to our website at <https://www.diodes.com/design/support/packaging/diodes-packaging/>.

## Marking Information



ME = Product Type Marking Code  
 YM = Date Code Marking  
 Y or  $\bar{Y}$  = Year (ex: H = 2020)  
 M or  $\bar{M}$  = Month (ex: 9 = September)

### Date Code Key

Year	2020	2021	2022	2023	2024	2025	2026	2027	2028			
Code	H	I	J	K	L	M	N	O	P			
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D

**Maximum Ratings** (@  $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Source-Source Voltage			$V_{SSS}$	30	V
Gate-Source Voltage			$V_{GSS}$	$\pm 20$	V
Continuous Source Current (Note 5) $V_{GS} = 8V$	Steady State	$T_A = +25^\circ\text{C}$	$I_S$	13.0	A
		$T_A = +70^\circ\text{C}$		10.5	
Continuous Source Current (Note 5) $V_{GS} = 4.5V$	Steady State	$T_A = +25^\circ\text{C}$	$I_S$	11.5	A
		$T_A = +70^\circ\text{C}$		9.0	
Pulsed Source Current (Note 6)			$I_{SM}$	80	A

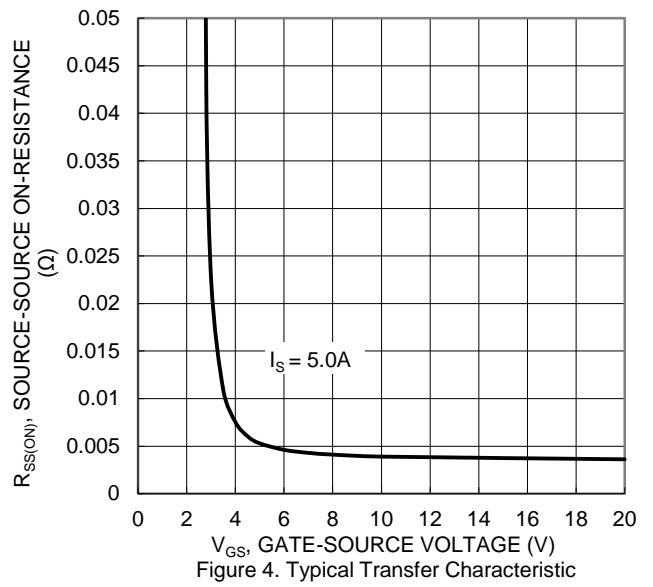
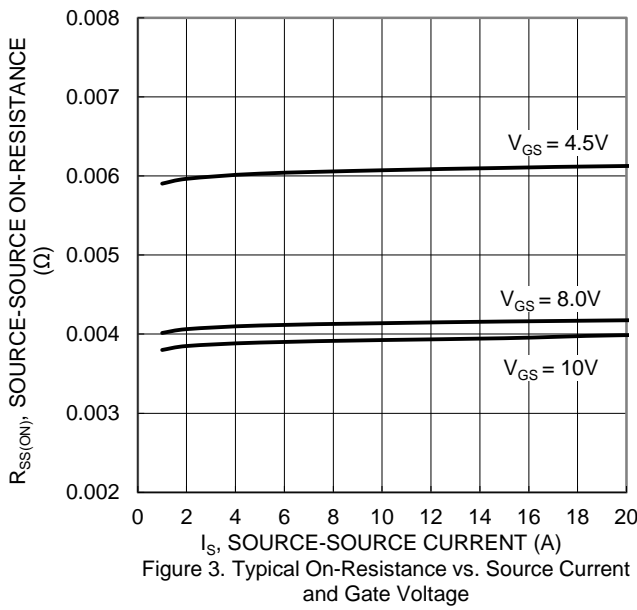
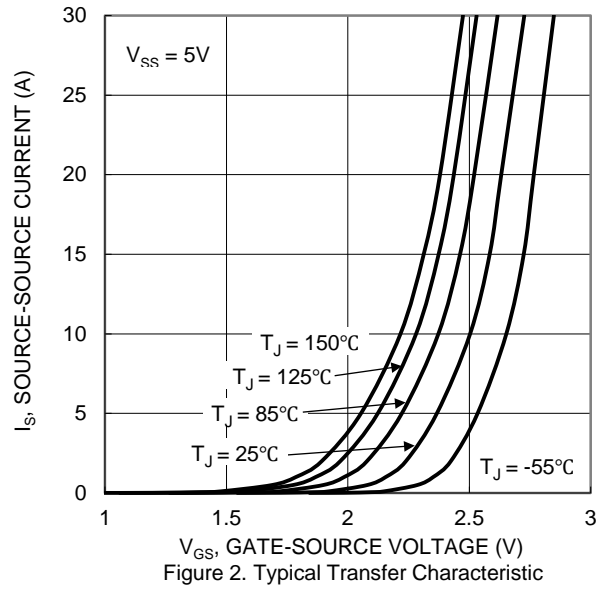
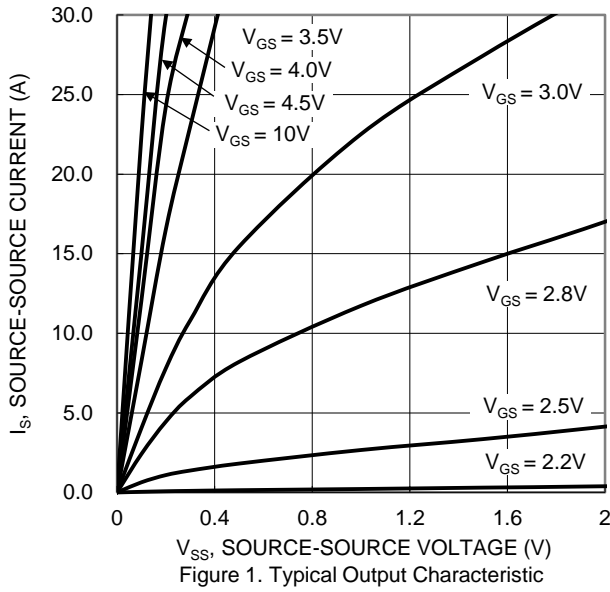
**Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 7)	$P_D$	0.8	W
Thermal Resistance, Junction to Ambient @ $T_A = +25^\circ\text{C}$ (Note 7)	$R_{\theta JA}$	162	$^\circ\text{C/W}$
Power Dissipation (Note 5)	$P_D$	1.8	W
Thermal Resistance, Junction to Ambient @ $T_A = +25^\circ\text{C}$ (Note 5)	$R_{\theta JA}$	68	$^\circ\text{C/W}$
Operating and Storage Temperature Range	$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

**Electrical Characteristics** (@  $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 8)</b>						
Source-Source Breakdown Voltage	$BV_{SSS}$	30	—	—	V	$V_{GS} = 0V, I_S = 1mA$
Zero Gate Voltage Drain Current $T_J = +25^\circ\text{C}$	$I_{SSS}$	—	—	1	$\mu\text{A}$	$V_{SS} = 24V, V_{GS} = 0V$
Gate-Source Leakage	$I_{GSS}$	—	—	$\pm 10$	$\mu\text{A}$	$V_{GS} = \pm 20V, V_{SS} = 0V$
<b>ON CHARACTERISTICS (Note 8)</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	1.3	—	2.2	V	$V_{SS} = 10V, I_S = 1mA$
		2.5	4.6	5.5		$V_{GS} = 10V, I_S = 5A$
Static Source-Source On-Resistance	$R_{SS(ON)}$	2.7	4.8	7.2	m $\Omega$	$V_{GS} = 8V, I_S = 5A$
		3.0	6.3	9.0		$V_{GS} = 4.5V, I_S = 5A$
		—	0.95	1.2	V	$V_{GS} = 0V, I_S = 5A$
Diode Forward Voltage	$V_{SS}$	—	0.95	1.2	V	$V_{GS} = 0V, I_S = 5A$
<b>DYNAMIC CHARACTERISTICS (Note 9)</b>						
Input Capacitance	$C_{ISS}$	—	2235	—	pF	$V_{SS} = 15V, V_{GS} = 0V, f = 1.0MHz$
Output Capacitance	$C_{OSS}$	—	414	—		
Reverse Transfer Capacitance	$C_{RSS}$	—	274	—		
Total Gate Charge	$Q_g$	—	17.7	—	nC	$V_{SS} = 15V, V_{GS} = 4.5V, I_S = 5A$
Gate-Source Charge	$Q_{gs}$	—	4.9	—		
Gate-Drain Charge	$Q_{gd}$	—	6.1	—		
Gate Charge at $V_{TH}$	$Q_{g(TH)}$	—	3.0	—		
Turn-On Delay Time	$t_{D(ON)}$	—	5.6	—	ns	$V_{SS} = 15V, V_{GS} = 10V, I_S = 5A$
Turn-On Rise Time	$t_R$	—	8.7	—		
Turn-Off Delay Time	$t_{D(OFF)}$	—	41.6	—		
Turn-Off Fall Time	$t_F$	—	20.9	—		

- Notes:
- Device mounted on FR-4 material with  $1\text{inch}^2$  ( $6.45\text{cm}^2$ ), 2oz. (0.071mm thick) Cu.
  - Repetitive rating, pulse width limited by junction temperature.
  - Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.
  - Short duration pulse test used to minimize self-heating effect.
  - Guaranteed by design. Not subject to production testing.



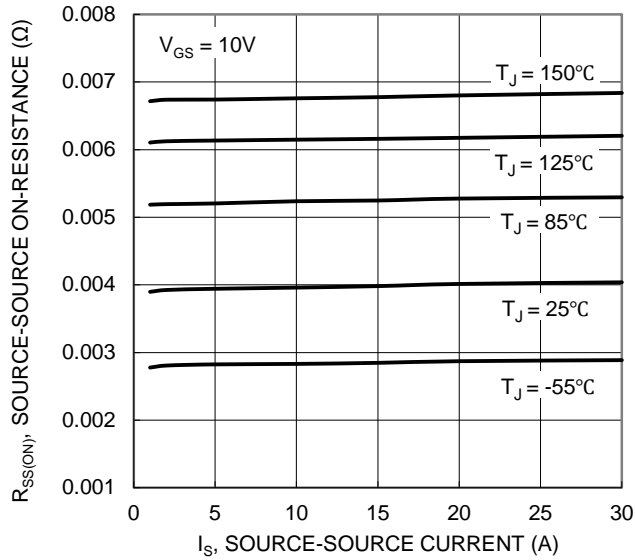


Figure 5. Typical On-Resistance vs. Source Current and Junction Temperature

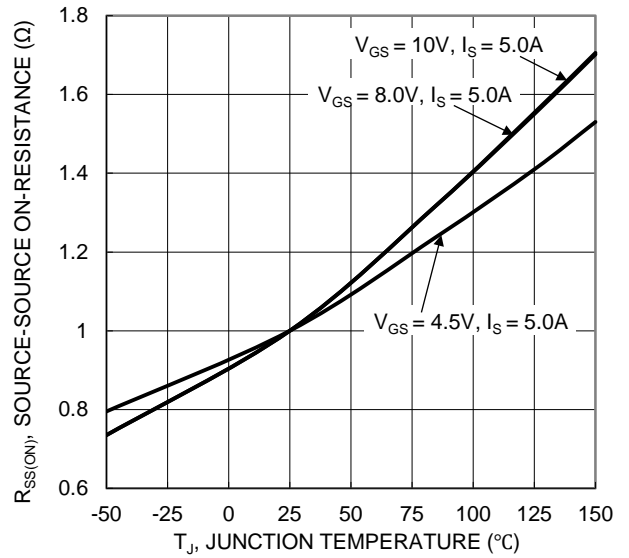


Figure 6. On-Resistance Variation with Junction Temperature

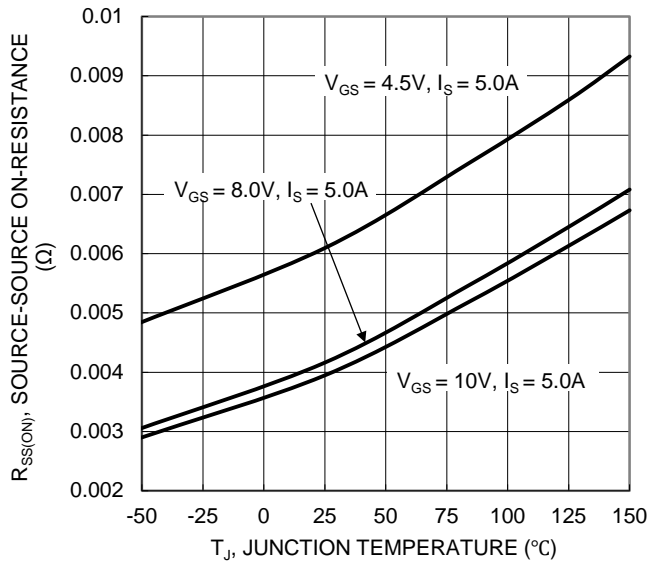


Figure 7. On-Resistance Variation with Junction Temperature

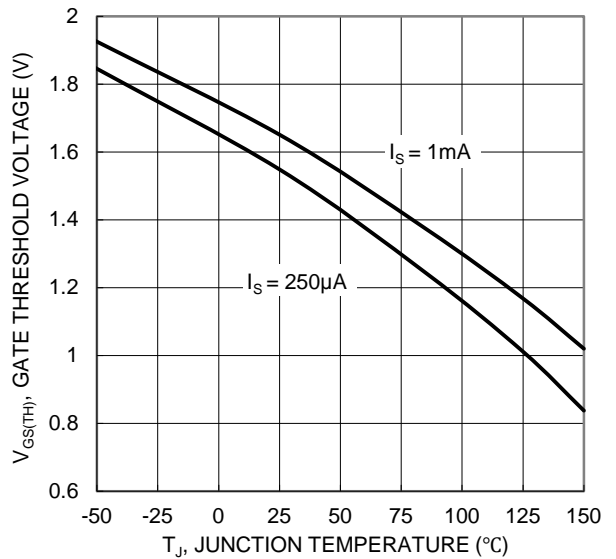


Figure 8. Gate Threshold Variation vs. Junction Temperature

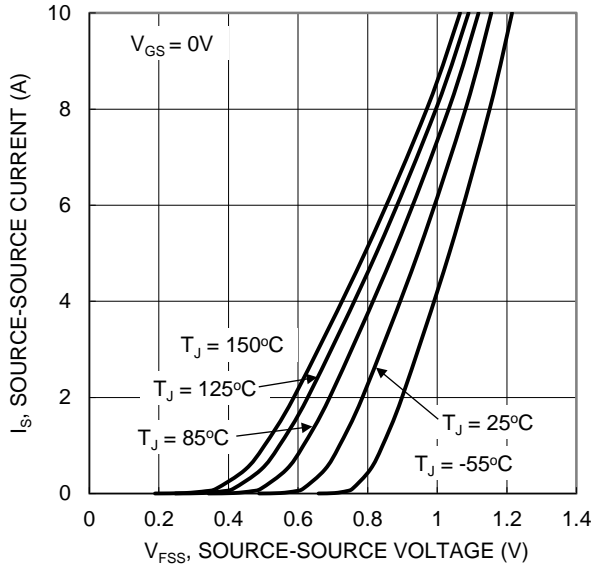


Figure 9. Diode Forward Voltage vs. Current

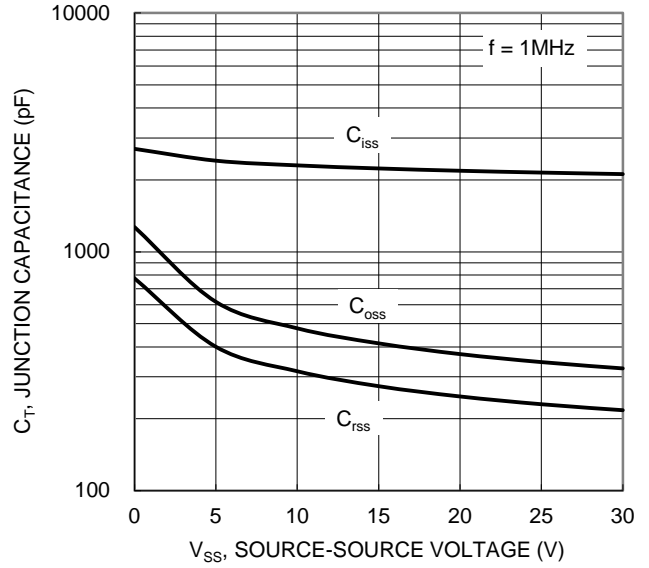


Figure 10. Typical Junction Capacitance

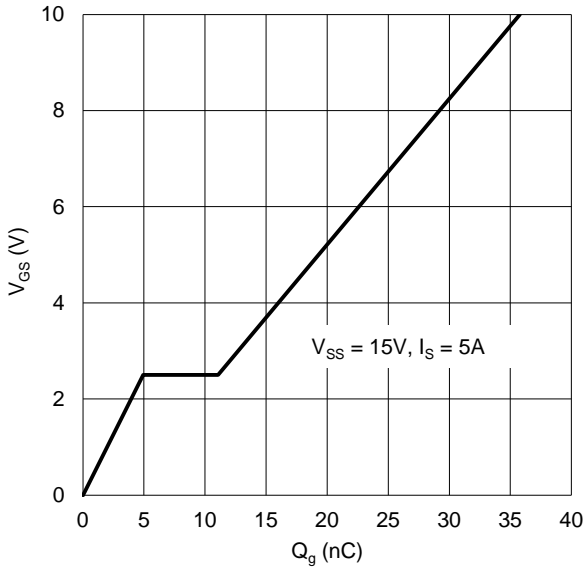


Figure 11. Gate Charge

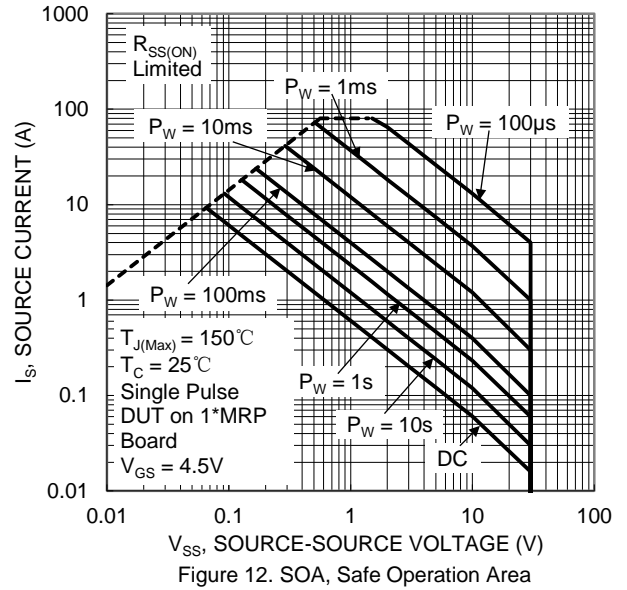


Figure 12. SOA, Safe Operation Area

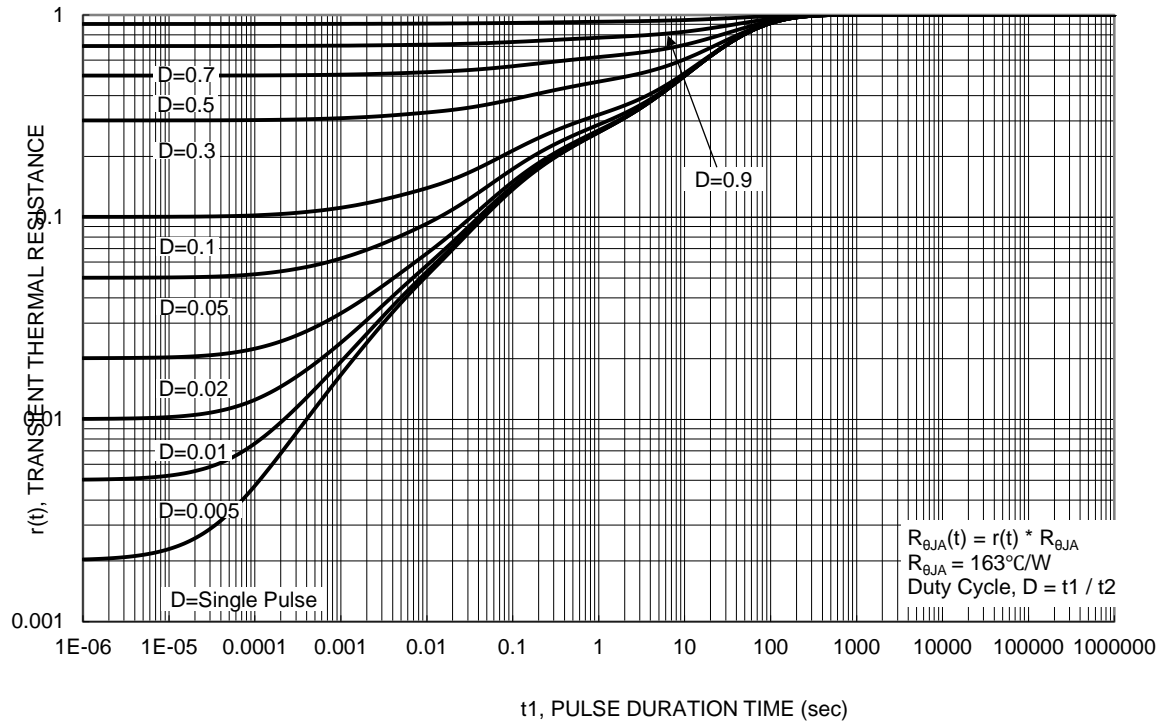
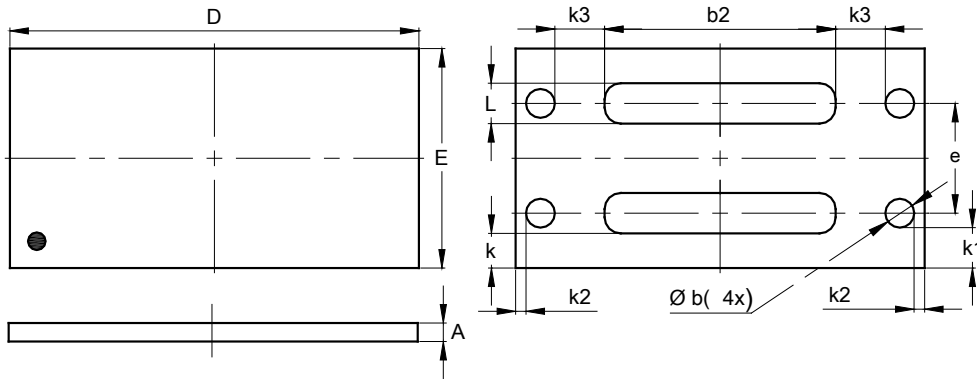


Figure 13. Transient Thermal Resistance

## Package Outline Dimensions

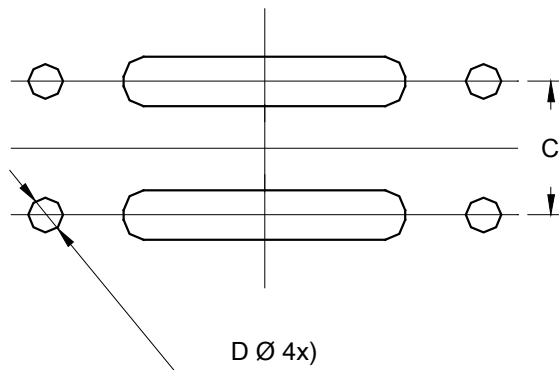
Please see <http://www.diodes.com/package-outlines.html> for the latest version.



X4-DSN3519-6			
Dim	Min	Max	Typ
A	0.09	0.16	0.11
b	--	--	0.25
b2	--	--	2.00
D	3.45	3.55	3.50
E	1.85	1.95	1.90
e	--	--	0.95
k	--	--	0.30
k1	--	--	0.35
k2	--	--	0.085
k3	--	--	0.415
L	--	--	0.35
All Dimensions in mm			

## Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.



Dimensions	Value (in mm)
C	0.95
X	0.25

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